```
(19)
                                                          (KR)
                                (12)
                                                         (B1)
(51) 。 Int. Cl.<sup>7</sup>
                                                           (45)
                                                                            2004 10 06
H01L 21/28
                                                            (11)
                                                                            10-0451504
                                                           (24)
                                                                            2004 09 23
(21)
                      10-2001-0061886
                                                        (65)
                                                                           10-2003-0029399
                                                        (43)
(22)
                      2001 10 08
                                                                           2003 04 14
(73)
                                               136-1
(72)
                                                     107-203
(74)
(54)
  8
  1
           8
  5
```

(inorganic arc layer)

9

21 : 25 :

35a : 35b : 23:

27:

31:

33: PE-USG 35:

가

TEM

```
가
                                                     (SEG)
                                       가
              (CMP)
                                                 0.16 µm
                                                                                          (gap-fill)
                               (CMP)
                                                     (silicon recess etch)
                                          (SEG; selective epitaxial growth)
                                           (SEG)
                                                                                  )
                                             (SAC; self-aligned contact)
                       (SEG)
                                                       (selectivity),
                                                                                  (thermal stress)
              (facet generation)
                                                            850
                        (LPCVD)
        가
                                                                 (thermal growth)
                                                                                       가
  1
                                                                                   (1)
                                                                                                      (3)
                       (3)
                                                 (5)
                                                      (5)
                                                                               (1)
                       (3)
                                          (5)
                                                                 (1)
                                                                                    (7)
          2
                                               (7)
                                                                                (9)
                                                 (9)
                                                                                                        (9)
          3
                                                                         (7)
                        (11)
                                                             (silicon recess etch)
                           (11)
                                  CMP
      (9)
                                                                            (11a)
                                                                               0.16 \mu m
      (high aspect ratio)
                                                                                                           (C
                                       (poly)
MP)
                                                          (CMP
                                                                                      )
                                       ( tube type LPCVD)
                                                                          (in-situ cleaning)
                                                        가
3
                                                                                                     (contact r
                                                                   가
                               (SEG)
esistance)
           가
                                                                                                          (pho
sphorus)
                                                     )
                                                                                (
                                                                                       )
               (
```

- 2 -

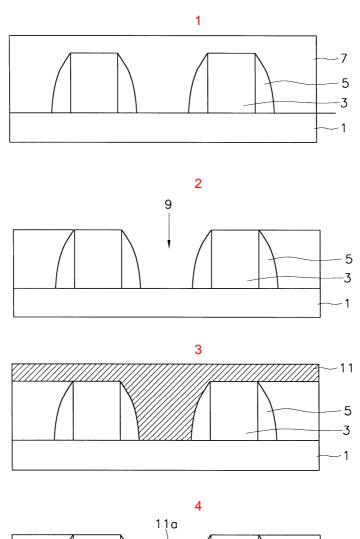
```
( )
        (SEG plug)
                                                  (selective epitaxial growth of silicon)
                            , LPCVD
                                                                                            (HCI
         가
                                                                   가 가
)
                                                       (TCE; thermal coefficient of expansion)가
                                                     (SEG)
                      , UHV-CVD
                                       900
                                                                                          10
                                                                                   가
                  가
                                             가
                         (SEG)
                                                      (over-growth)
            CMP
                                        가
                                                      (SEG)
      )
  5
           8
                                                                        가
  9
TEM
                                                                                           (21)
                                                       (23)
                    (21)
                                                                       (25)
   (25)
                             (21)
                                                                                         (27)
                                (21)
                                                (27)
                                                                         (21)
                        (27)
                                                         (29)
                 (27)
                                     (21)
                                                                                    PE-USG
                                                            (inorganic arc layer)(31)
                        (27)
  (33)
                                       (31)
                                                     10
                                                            100
                                                                  , PE-USG
        300
                 1000
                                                     (step coverage) 50 %
                                       100 sccm, N _2 O
                                                                                    1000
                (31)
                      SiH 4
                                50
                                                           100
                                                                   300 sccm, He
                                                                                              30
                                       450 ,
                  10 Torr,
                               300
                                                    50
00 sccm,
                                                           150 W
         PE-USG
                                 , SiH _{4} , N _{2} O, He
                                                                               가
                      (33)
                      350
                                                       1000 W
    0.1
            50 Torr,
                                  550 , 100
```

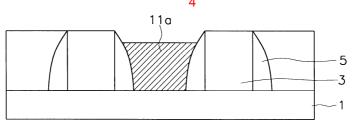
```
(RIE; reactive ion etching)
                                                                                  ( )
         6
                    (silicon window)
                    , PE-USG
200 400
                                            (33)
                                                                                 (25)
       (31)
                     (27)
                                            (31)
                                           HF
                                                            50 500
        PE-USG
                    (33)
                                                                                   (DI) 50
    100
                                                  가 50% PE-USG 600
                   300 400
                                               , LPCVD
           가
                                   (in-situ)
thermal budget)
                RTP(rapid thermal processing)
                         . , RTP
                                                               950
                                                                          ( (ramping rate
                                                     , 550 630
         ))
                          950 30
( )
(33)
                 , 750
                                               150
                                                                            (21)
                                                             (31)
                                                                                 (33)
                              UHVCVD
                                                              가
               LPCVD
   , LPCVD
                                 (35)
LPCVD
                               (SEG)
                                                   , Si-H-Cl
                                                                                 DCS-H 2 -HCI
가 MS-H <sub>2</sub> -HCI
                              7 750 950 , 5 150 Torr, DCS 0.1
1.0 slm , H <sub>2</sub> 30 150 slm , 750 950 , 5 150 Torr, MS(monosilane)
0.5 5.0 slm , H <sub>2</sub> 30 150 slm
1 10% PH <sub>3</sub> /H <sub>2</sub> 0.1 1.5 slm , SEG
   , DCS-H 2 -HCI
   1 slm , HCl
                   0.1
   , MS-H 2 -HCI
    0.1 1 slm , HCl
                                                                                      , SEG
600
                                                                             1000
                       60 %
                               100 %
    1000
                   (21)
                                                (35a)
                         (35b)
   (31)
                         , UHVCVD
                                                               (35)
                                                              (SEG)
가
UHVCVD
                                   (35)
                                                SEG
                                                                            (incubation thickne
ss) , 800 1200 .
, Cl <sub>2</sub> 가 가 SEG
                                             가
                                                                           가
   , UHVCVD
                           Cl<sub>2</sub> 가
                                            , Si <sub>2</sub> H <sub>6</sub> + Cl <sub>2</sub> + H <sub>2</sub>
        10 sccm, 0 0 20 sccm
                                                                            , H <sub>2</sub>
                                                                                          10 %
PH <sub>3</sub>
                                                                 600
                                                                          800 ,
          가
  50 mTorr
                           가 가 . , GeH <sub>4</sub> 0 10 ( ) 60 100 %
                                                                         . , SSG
                                                                                   가 .
PE-USG
                                                     (inorganic arc layer)
          (SEG)
                                                                                   SEG
,
가
                  가
                                             가
                                     SEG
  30 %
          )
         (SSG)
```

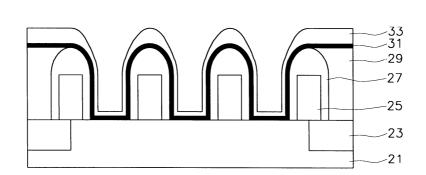
```
가
                                                  PE-USG
               (SAC)
                   , SEG
                                                                 가
                                                                                            가
                    , 가
                                   UHVCVD
                                                                            가
      UHVCVD
                                                   가
                    LPCVD
                                                                                            가
                                               (low therma budget process)
              가
        가
                                               가
                                                                                가 가
(57)
      1.
      2.
 1
      3.
                            SiH <sub>4</sub> 50 100 sccm, N <sub>2</sub> O 100 300 sccm, He
                                                                                          1000
    3000 sccm
      4.
                                                                        50 150 W
 1
                                1
                                     10 Torr,
                                                   300 450 ,
      5.
                                  10 100
 1
      6.
      7.
                                      LPCVD UHVCVD
 1
      8.
 1
      9.
 8
      10.
 9
                          PE-USG
      11.
                                      , SiH _4 \phantom{0} 10 \phantom{0} 200 sccm, N _2 O \phantom{0} O _2 1000 sccm, \phantom{0} 0.1 \phantom{0} 100 Torr, \phantom{0} 350 \phantom{0} 600 ,
 10
                   PE-USG
  100
            3000 sccm, He 0
  100
12.
            1000 W
 10 , PE-USG
                                         300 1000
                                                                     가 50 %
```

```
9
       14.
                                 NF<sub>3</sub>,O<sub>2</sub>가
                                                                                        10 50 s
 13
                                                                           , NF <sub>3</sub>
ccm, O 2
                                                  2000 sccm,
                                                                   1
                      300 sccm, He 100
                                                                           200 W,
                                                                                        1mTorr
10 Torr,
                        200
       15.
13
                                        HF
                                                                    , 50
                                                                             500
                                                                                           50
100
       16.
                                 NF_3, O_2가
 14
                                                                                        10 50 s
                                                                           , NF _3
ccm, O<sub>2</sub>
               30
                      300 sccm, He 100
                                                  2000 sccm,
                                                                    1
                                                                           200 W,
                                                                                        1mTorr
10 Torr,
                       200
       17.
 13
       18.
 17
       19.
 17
                                                        RTP
      20.
 19
                                       , 5
                                               150slm
                                                                         200 Torr
                                                                                          , 750
                  5
                         30
950
       21.
 19
                                    RTP
                                                           , RTP
                                                                              950
                       10
                              100 /
      22.
                                              , DCS-H <sub>2</sub> - HCl 가
0.1 1 slm
                                                                                                 75
 1
      950 ,
                      150 Torr, DCS
                  5
                                                                           0.1
                                                                                  1.0 slm
             150 slm
      30
      23.
                                                    , MS-H 2 -HCI
            5 150 Torr, MS (monosilane)
                                                  0.1 1 slm , HCl
                                                                                0.5
950
                                                                                        5.0 slm
       30
                 150 slm
      24.
                                       $\rm Si\ _2\ H\ _6\ +\ Cl\ _2\ +\ H\ _2}$ 20 sccm, $\rm 600\ \ 800\ ]
      10 sccm, 0 5 sccm, 0
      25.
                                                   , 1 10% PH <sub>3</sub>가 H<sub>2</sub>가
  1
      26.
 25
                                                GeH <sub>4</sub> 가
                                                             0 10 sccm
      27.
                                                              UHVCVD
                                                                                   SEG
                                                                                            UHVCV
 1
D
```

13.

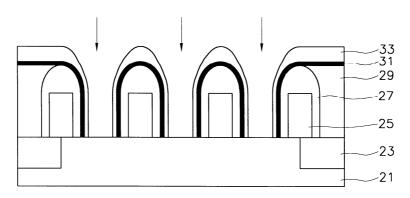




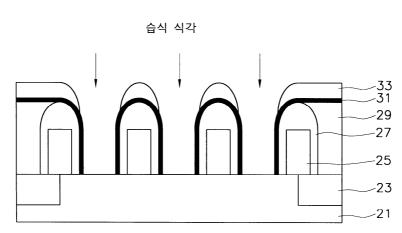


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반응성 이온 식각



7



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